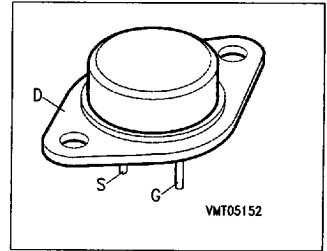


SIPMOS® Power Transistors

- N channel
- Enhancement mode
- Avalanche-rated

BUZ 54
BUZ 54 A



Type	V_{DS}	I_D	$R_{DS(on)}$	Package ¹⁾	Ordering Code
BUZ 54	1000 V	5.1 A	2.0 Ω	TO-204 AA	C67078-S1010-A2
BUZ 54 A	1000 V	4.5 A	2.6 Ω	TO-204 AA	C67078-S1010-A3

Maximum Ratings

Parameter	Symbol	BUZ		Unit
		54	54 A	
Continuous drain current, $T_C = 25\text{ }^\circ\text{C}$	I_D	5.1	4.5	A
Pulsed drain current, $T_C = 25\text{ }^\circ\text{C}$	$I_{D\text{ puls}}$	20	18	
Avalanche current, limited by $T_{j\text{ max}}$	I_{AR}	5.1		
Avalanche energy, periodic limited by $T_{j\text{ (max)}}$	E_{AR}	18		mJ
Avalanche energy, single pulse $I_D = 5.1\text{ A}, V_{DD} = 50\text{ V}, R_{GS} = 25\text{ }\Omega$ $L = 62\text{ mH}, T_j = 25\text{ }^\circ\text{C}$	E_{AS}	850		
Gate-source voltage	V_{GS}	± 20		V
Power dissipation, $T_C = 25\text{ }^\circ\text{C}$	P_{tot}	125		W
Operating and storage temperature range	T_j, T_{stg}	- 55 ... + 150		$^\circ\text{C}$
Thermal resistance, chip-case	$R_{th\text{ JC}}$	≤ 1.0		K/W
DIN humidity category, DIN 40 040		C		-
IEC climatic category, DIN IEC 68-1		55/150/56		

1) See chapter Package Outlines.

Electrical Characteristics

at $T_j = 25\text{ °C}$, unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Static characteristics

Drain-source breakdown voltage $V_{GS} = 0\text{ V}$, $I_D = 0.25\text{ mA}$	$V_{(BR)DSS}$	1000	–	–	V
Gate threshold voltage $V_{GS} = V_{DS}$, $I_D = 1\text{ mA}$	$V_{GS(th)}$	2.1	3.0	4.0	
Zero gate voltage drain current $V_{DS} = 1000\text{ V}$, $V_{GS} = 0\text{ V}$ $T_j = 25\text{ °C}$ $T_j = 125\text{ °C}$	I_{DSS}	– –	0.1 100	1.0 1000	μA
Gate-source leakage current $V_{GS} = 20\text{ V}$, $V_{DS} = 0\text{ V}$	I_{GSS}	–	10	100	nA
Drain-source on-resistance $V_{GS} = 10\text{ V}$, $I_D = 3.2\text{ A}$	$R_{DS(on)}$	– –	1.7 2.3	2.0 2.6	Ω
					BUZ 54 BUZ 54 A

Dynamic characteristics

Forward transconductance $V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$, $I_D = 3.2\text{ A}$	g_{fs}	2.5	5.2	–	S
Input capacitance $V_{GS} = 0\text{ V}$, $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$	C_{iss}	–	1700	2200	pF
Output capacitance $V_{GS} = 0\text{ V}$, $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$	C_{oss}	–	170	300	
Reverse transfer capacitance $V_{GS} = 0\text{ V}$, $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$	C_{rss}	–	80	40	
Turn-on time t_{on} , ($t_{on} = t_{d(on)} + t_r$) $V_{DD} = 30\text{ V}$, $V_{GS} = 10\text{ V}$, $I_D = 2.5\text{ A}$, $R_{GS} = 50\text{ }\Omega$	$t_{d(on)}$	–	30	45	ns
	t_r	–	100	160	
Turn-off time t_{off} , ($t_{off} = t_{d(off)} + t_f$) $V_{DD} = 30\text{ V}$, $V_{GS} = 10\text{ V}$, $I_D = 2.5\text{ A}$, $R_{GS} = 50\text{ }\Omega$	$t_{d(off)}$	–	400	520	
	t_f	–	130	170	

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Electrical Characteristics (cont'd)

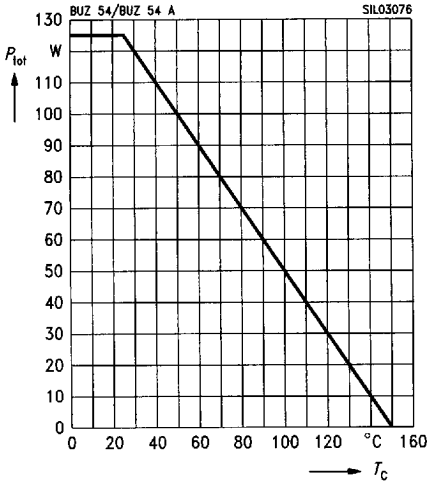
at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Reverse diode					
Continuous reverse drain current $T_C = 25\text{ }^\circ\text{C}$	I_S	–	–	5.1	A
BUZ 54 BUZ 54 A		–	–	4.5	
Pulsed reverse drain current $T_C = 25\text{ }^\circ\text{C}$	I_{SM}	–	–	20	
BUZ 54 BUZ 54 A		–	–	18	
Diode forward on-voltage $I_S = 10\text{ A}$, $V_{GS} = 0\text{ V}$	V_{SD}	–	1.0	1.2	V
Reverse recovery time $V_R = 100\text{ V}$, $I_F = I_S$, $di_F / dt = 100\text{ A}/\mu\text{s}$	t_{rr}	–	1.5	–	μs
Reverse recovery charge $V_R = 100\text{ V}$, $I_F = I_S$, $di_F / dt = 100\text{ A}/\mu\text{s}$	Q_{rr}	–	6.5	–	μC

Characteristics at $T_j = 25^\circ\text{C}$, unless otherwise specified.

Total power dissipation

$$P_{\text{tot}} = f(T_C)$$

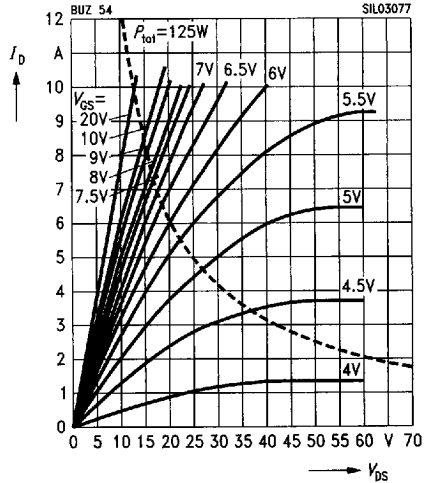


Typ. output characteristics

$$I_D = f(V_{DS})$$

parameter: $t_p = 80 \mu\text{s}$

BUZ 54



Typ. output characteristics

$$I_D = f(V_{DS})$$

parameter: $t_p = 80 \mu\text{s}$

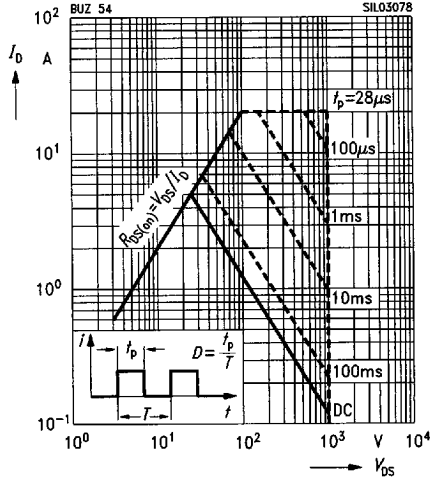
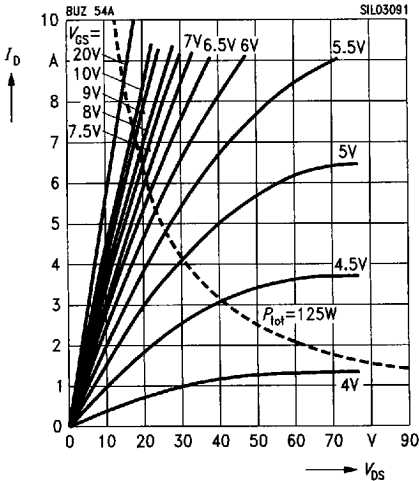
BUZ 54 A

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Safe operating area

$$I_D = f(V_{DS})$$

parameter: $D = 0.01, T_C = 25^\circ\text{C}$

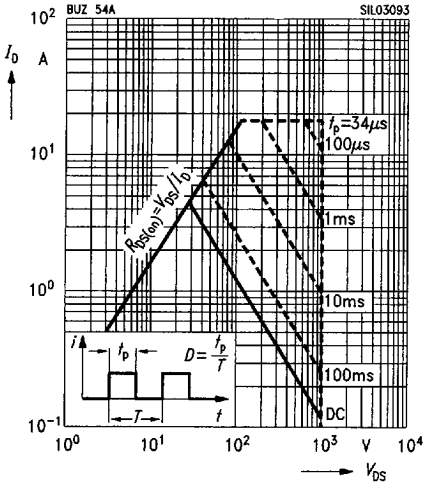


Safe operating area

$$I_D = f(V_{DS})$$

BUZ 54 A

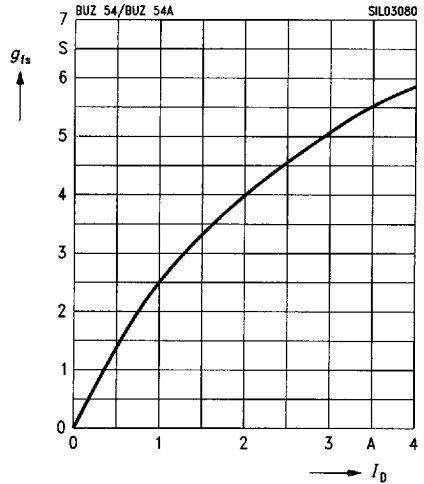
parameter: $D = 0.01$, $T_C = 25^\circ\text{C}$



Typ. forward transconductance

$$g_{fs} = f(I_D)$$

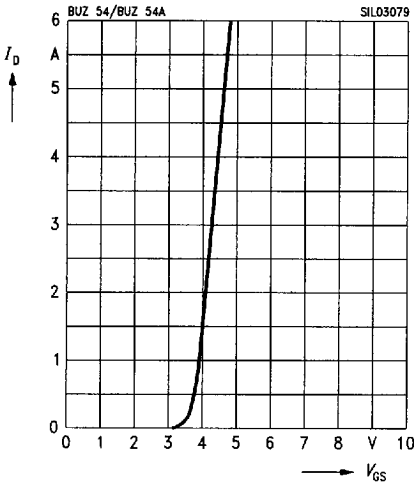
parameter: $t_p = 80 \mu\text{s}$



Typ. transfer characteristics

$$I_D = f(V_{GS})$$

parameter: $t_p = 80 \mu\text{s}$, $V_{DS} = 25 \text{ V}$

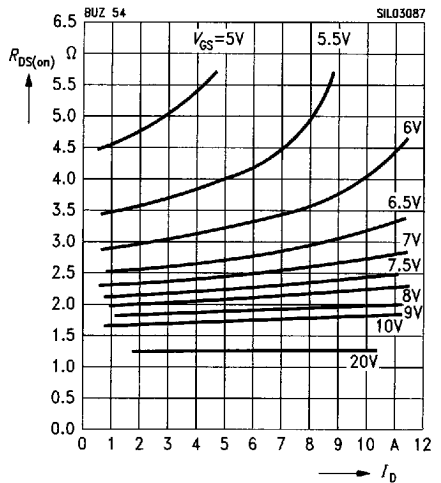


Typ. drain-source on-resistance

$$R_{DS(on)} = f(I_D)$$

BUZ 54

parameter: V_{GS}

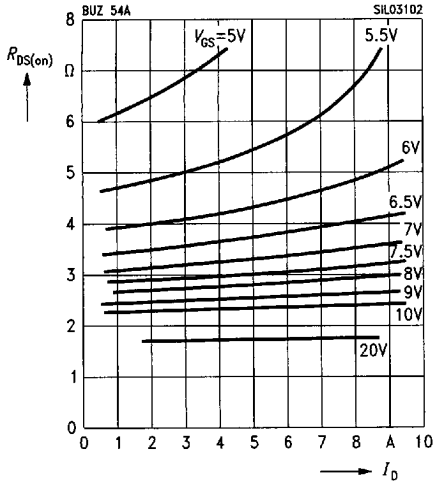


Typ. drain-source on-resistance

$R_{DS(on)} = f(I_D)$

parameter: V_{GS}

BUZ 54 A

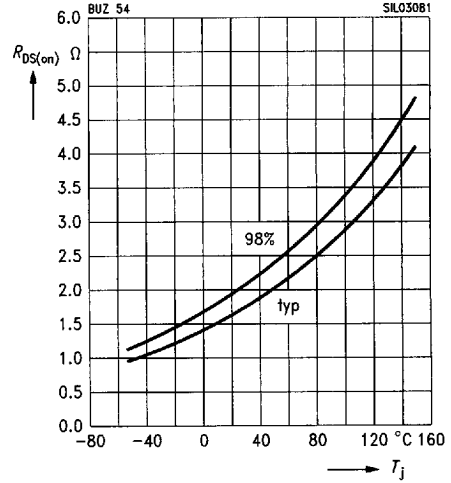


Drain-source on-resistance

$R_{DS(on)} = f(T_j)$

parameter: $I_D = 3.2$ A, $V_{GS} = 10$ V, (spread)

BUZ 54

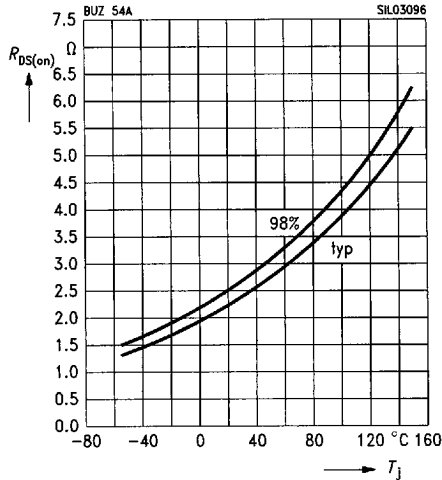


Drain-source on-resistance

$R_{DS(on)} = f(T_j)$

parameter: $I_D = 3.2$ A, $V_{GS} = 10$ V, (spread)

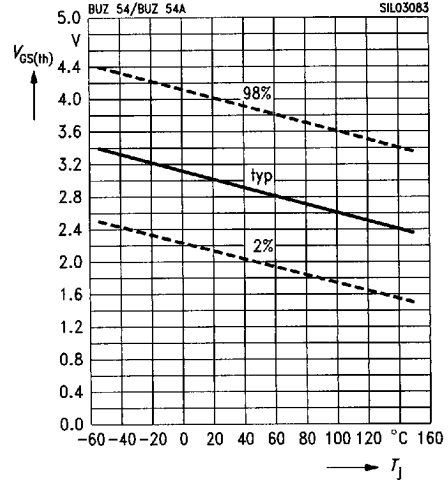
BUZ 54 A



Gate threshold voltage

$V_{GS(th)} = f(T_j)$

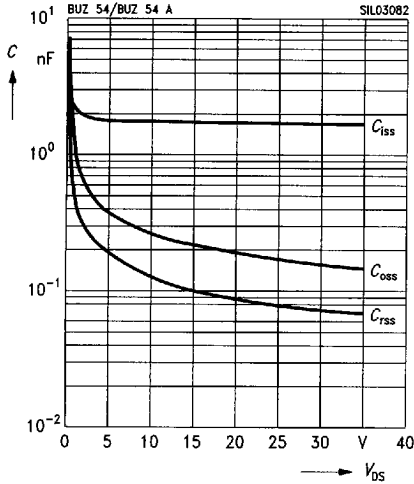
parameter: $V_{GS} = V_{DS}$, $I_D = 1$ mA, (spread)



Typ. capacitances

$$C = f(V_{DS})$$

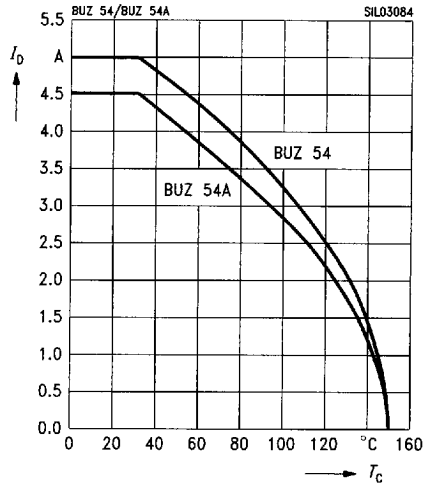
parameter: $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$



Drain current

$$I_D = f(T_C)$$

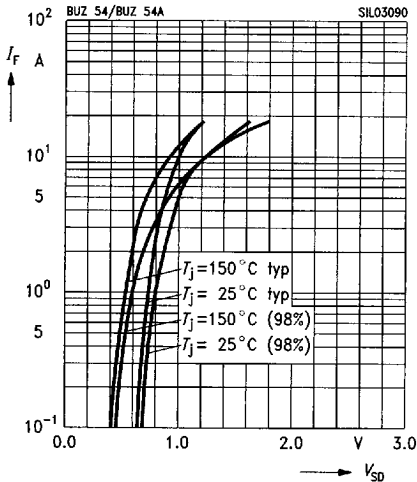
parameter: $V_{GS} \geq 10 \text{ V}$



Forward characteristics of reverse diode

$$I_F = f(V_{SD})$$

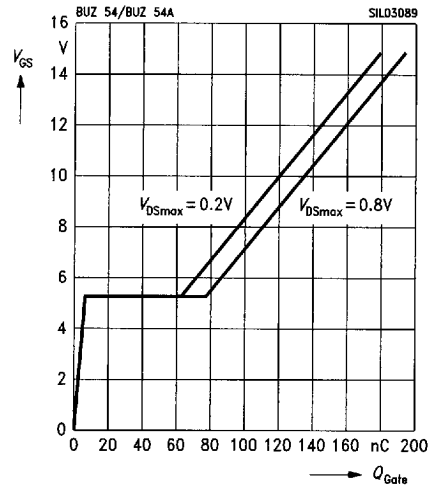
parameter: $T_i, t_p = 80 \mu\text{s}$, (spread)



Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

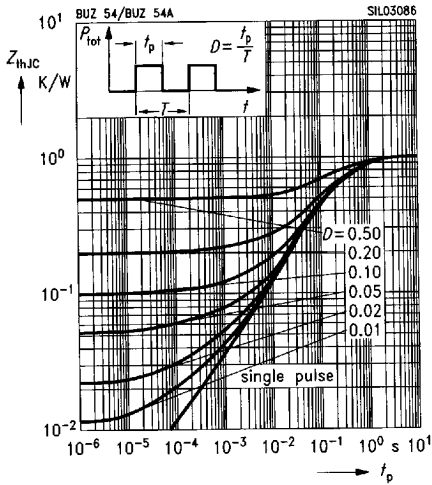
parameter: $I_{D,puls} = 7.5 \text{ A}$



Transient thermal impedance

$$Z_{thJC} = f(t_p)$$

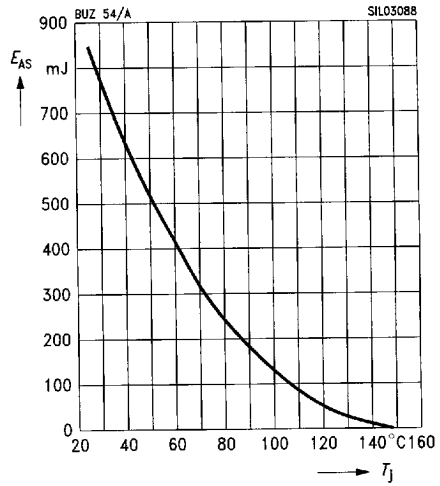
$$\text{parameter: } D = t_p / T$$



Avalanche energy $E_{AS} = f(T_J)$

$$\text{parameter: } I_D = 5 \text{ A, } V_{DD} = 50 \text{ V}$$

$$R_{GS} = 25 \Omega, L = 64.6 \text{ mH}$$



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